


<b>Search Notes</b> 	<b>Application/Control No.</b>		<b>Applicant(s)/Patent under Reexamination</b>	
	10/709,843		BALSDON ET AL.	
	<b>Examiner</b>		<b>Art Unit</b>	
	Phallaka Kik		2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	13,14,9,10	4/24/2006	PK
Above	updated	8/17/2006	PK
Above	updated	9/1/2006	PK
Above	new	9/1/2006	PK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
716	13,14,9	9/1/2006	PK
716	10	9/1/2006	PK
--USPGPUB (see attached)		9/1/2006	PK

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Cls/Sub searched: 716/1-18 (see attached)	4/24/2006	PK
Above updated search (see attached)	8/17/2006	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	4/24/2006	PK
All above updated and new search (see attached)	9/1/2006	OK
IEE/IEEE Xplore (see attached)	4/24/2006	PK